CERTIFICATION TEST REPORT

Report Number. : 13583138-E9V2

Applicant	:	SAMSUNG ELECTRONICS CO., LTD. 129 SAMSUNG-RO, YEONGTONG-GU, SUWON-SI, GYEONGGI-DO, 16677, KOREA
Model	:	SM-A526B/DS, SM-A526B
FCC ID	:	A3LSMA526B
EUT Description	:	GSM/WCDMA/LTE/5G Phablet with BT/BLE,DTS/UNII a/b/g/n/ac and NFC
Test Standard(s)	:	FCC CFR47 PART 27 SUBPART M

Date Of Issue:
February 01, 2021

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IAS ACCREDITED
Testing Laboratory
TL-637

Revision History

Rev.	Issue Date	Revisions	Revised By
V1	01/22/21	Initial issue	Sungeun Lee
V2	02/01/21	Updated to address TCB's question	Sungeun Lee

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1. ATTESTATION OF TEST RESULTS

COMPANY NAME:	SAMSUNG ELECTRONICS CO., LTD.
EUT DESCRIPTION:	GSM/WCDMA/LTE/5G Phablet with BT/BLE,DTS/UNII a/b/g/n/ac and NFC
MODEL NUMBER:	SM-A526B/DS, SM-A526B
SERIAL NUMBER:	R3CNB0CBLDW (CONDUCTED) R3CNB0CBGTZ (RADIATED)
DATE TESTED:	JAN 19, 2021 – FEB 01, 2021;

APPLICABLE STANDARDS	
STANDARD	**TEST RESULTS**
FCC PART 27 M	Pass

UL Korea, Ltd. tested the above equipment in accordance with the requirements set forth in the above standards. All indications of Pass/Fail in this report are opinions expressed by UL Korea, Ltd. based on interpretations and/or observations of test results. Measurement Uncertainties were not taken into account and are published for informational purposes only. The test results show that the equipment tested is capable of demonstrating compliance with the requirements as documented in this report.

Note: The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein. This document may not be altered or revised in any way unless done so by UL Korea, Ltd. and all revisions are duly noted in the revisions section. Any alteration of this document not carried out by UL Korea, Ltd. will constitute fraud and shall nullify the document. This report must not be used by the client to claim product certification, approval, or endorsement by IAS, any agency of the Federal Government, or any agency of any government.

8/
Approved & Released For
UL Korea, Ltd. By:

Junwhan Lee
Suwon Lab Engineer
UL Korea, Ltd.

Tested By:

Sungeun Lee
Suwon Lab Engineer
UL Korea, Ltd.

2. TEST METHODOLOGY

The tests documented in this report were performed in accordance with following methods.

1. FCC CFR 47 Part 2.
2. FCC CFR 47 Part 27.
3. ANSI TIA-603-E, 2016
4. ANSI C63.26, 2015
5. KDB 971168 D01 Power Meas License Digital Systems v03r01
6. KDB 412172 D01 Determing ERP and EIRP v01r01

3. FACILITIES AND ACCREDITATION

The test sites and measurement facilities used to collect data are located at 218 Maeyeong-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do,16675, Korea. Line conducted emissions are measured only at the 218 address. The following table identifies which facilities were utilized for radiated emission measurements documented in this report. Specific facilities are also identified in the test results sections.

218 Maeyeong-ro
☒ Chamber 1
☒ Chamber 2
☐ Chamber 3

UL Korea, Ltd. is accredited by IAS, Laboratory Code TL-637. The full scope of accreditation can be viewed at https://www.iasonline.org/wp-content/uploads/2017/05/TL-637-cert-New.pdf.

4. CALIBRATION AND UNCERTAINTY

4.1. MEASURING INSTRUMENT CALIBRATION

The measuring equipment utilized to perform the tests documented in this report has been calibrated in accordance with the manufacturer's recommendations, and is traceable to recognized national standards.

4.2. SAMPLE CALCULATION

Where relevant, the following sample calculation is provided:

EIRP = PSA reading with EUT worst orientation (dBm) + Path loss (dB) – cable loss(between the SG and substitution antenna) + Substitution Antenna Factor (dBi)

ERP = PSA reading with EUT worst orientation (dBm) + Path loss (dB) – cable loss(between the SG and substitution antenna)

(Path loss = Signal generator output – PSA reading with substitution antenna)

4.3. MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the apparatus:

PARAMETER	UNCERTAINTY
Conducted Disturbance, 0.15 to 30 MHz	3.01 dB
Radiated Disturbance, 30 MHz to 1 GHz	4.26 dB
Radiated Disturbance, 1 GHz to 18 GHz	5.90 dB
Radiated Disturbance, Above 18 GHz	5.49 dB

Uncertainty figures are valid to a confidence level of 95%.

4.4. DECISION RULE

Decision rule for statement(s) of conformity is based on Procedure 1, Clause 4.4.2 in IEC Guide 115:2007.

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5. EQUIPMENT UNDER TEST

5.1. DESCRIPTION OF EUT

The EUT is a GSM/WCDMA/LTE/5G Phablet with BT/BLE,DTS/UNII a/b/g/n/ac and NFC.
This test report addresses the WWAN operational mode.

This report covers the Samsung models SM-A526B/DS and SM-A526B.
These models are identical in hardware except SM-A526B has single SIM tray.
With some pre-scan, model SM-A526B/DS was set for final test.

5.2. MAXIMUM OUTPUT POWER

The transmitter has a maximum average radiated ERP / EIRP output powers as follows:
Note : Conducted output power results were excerpted from RF exposure test report (13583138-S1 FCC Report SAR).

LTE Band 41

FCC Part 27							
Band	Frequency Range [MHz]	BandWidth [MHz]	Modulation	Conducted		Radiated	
				Avg [dBm]	Avg [mW]	Avg [dBm]	Avg [mW]
Band 41	2496 ~ 2690	20	QPSK	24.6	291.0	20.83	121.06
			16QAM	23.8	238.3	20.09	102.09
			64QAM	22.7	187.9		
		15	QPSK	24.6	290.7	20.55	113.50
			16QAM	23.7	233.2	20.11	102.57
			64QAM	22.2	167.9		
		10	QPSK	**24.8**	**300.9**	22.05	160.32
			16QAM	23.9	245.1	**22.61**	**182.39**
			64QAM	22.2	167.9		
		5	QPSK	24.7	297.7	20.68	116.95
			16QAM	23.8	239.0	20.40	109.65
			64QAM	22.6	182.4		

5.3. DESCRIPTION OF AVAILABLE ANTENNAS

The radio utilizes a internal antenna for the [List the bands supported] with a maximum peak gain as follow:

Frequency (MHz)	Peak Gain (dBi)
LTE Band 41 2496 ~ 2690 MHz	-6.50

5.4. WORST-CASE ORIENTATION

For all LTE Bands, the worst-case scenario for all measurements is based on the average conducted output power measurement investigation results. Output power measurements were measured on QPSK, 16QAM and 64QAM modulations. It was found that QPSK and 16QAM results were worst case. All testing was performed using QPSK and 16QAM modulations to represent the worst case. However, the out of band emissions and spurious radiation were only performed on bandwidth and RB offset(with RB size 1) with the highest conducted power in QPSK.

Highest power setting for each bands				
LTE Band	**Frequency (MHz)**	**Bandwidth (MHz)**	**RB size**	**RB offset**
41	2501.0	10	1	25
	2593.0		1	25
	2685.0		1	25

The fundamental and radiated spurious emission were investigated in three orthogonal orientations X, Y and Z, it was determined that below orientation was worst-case orientation for each band.

Band	**ERP/EIRP**			**RSE**		
	X	**Y**	**Z**	**X**	**Y**	**Z**
LTE B41	O	-	-	O	-	-

Note : For ERP/EIRP testing, the EUT didn't attached with travel adapter. But radiated spurious testing, the EUT attached with travel adapter for the worst case condition. The EUT is continuously communicated with the call box during the tests.

5.5. DESCRIPTION OF TEST SETUP

SUPPORT EQUIPMENT

Support Equipment List				
Description	**Manufacturer**	**Model**	**Serial Number**	**FCC ID**
Charger	SAMSUNG	EP-TA200	N/A	N/A
Data Cable	SAMSUNG	EP-DR140AWE	N/A	N/A

I/O CABLE

I/O Cable List						
Cable No	**Port**	**# of identical ports**	**Connector Type**	**Cable Type**	**Cable Length (m)**	**Remarks**
1	DC Power	1	C Type	Shielded	1.0m	N/A

TEST SETUP

The EUT is continuously communicated with the call box during the tests.

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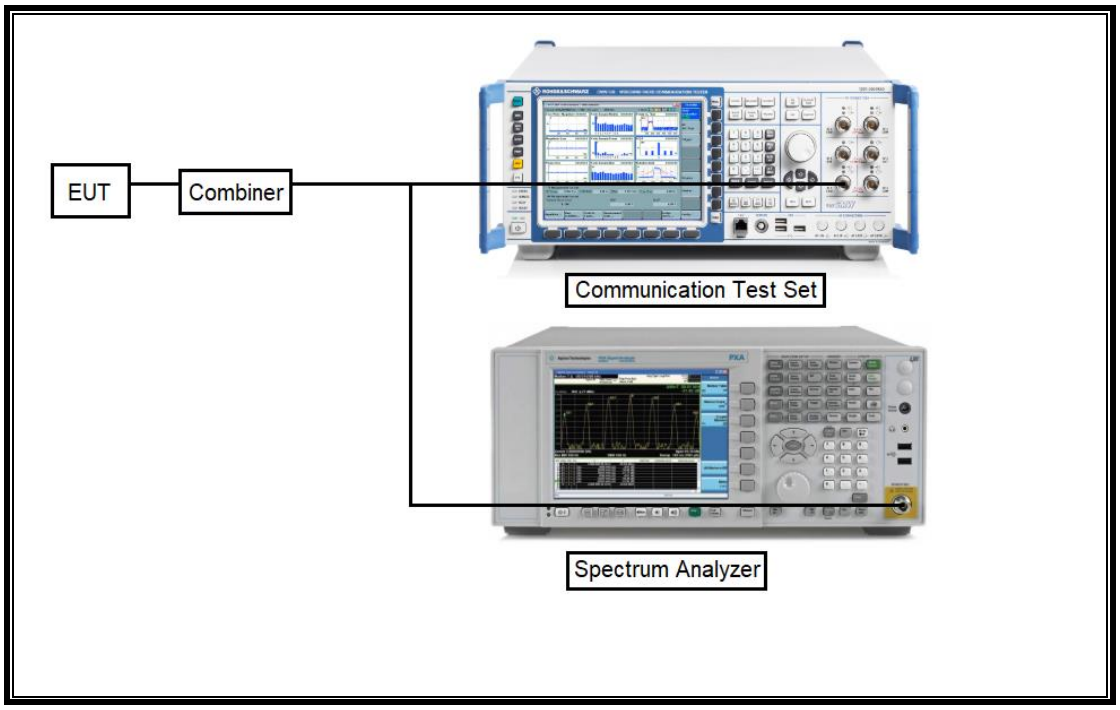
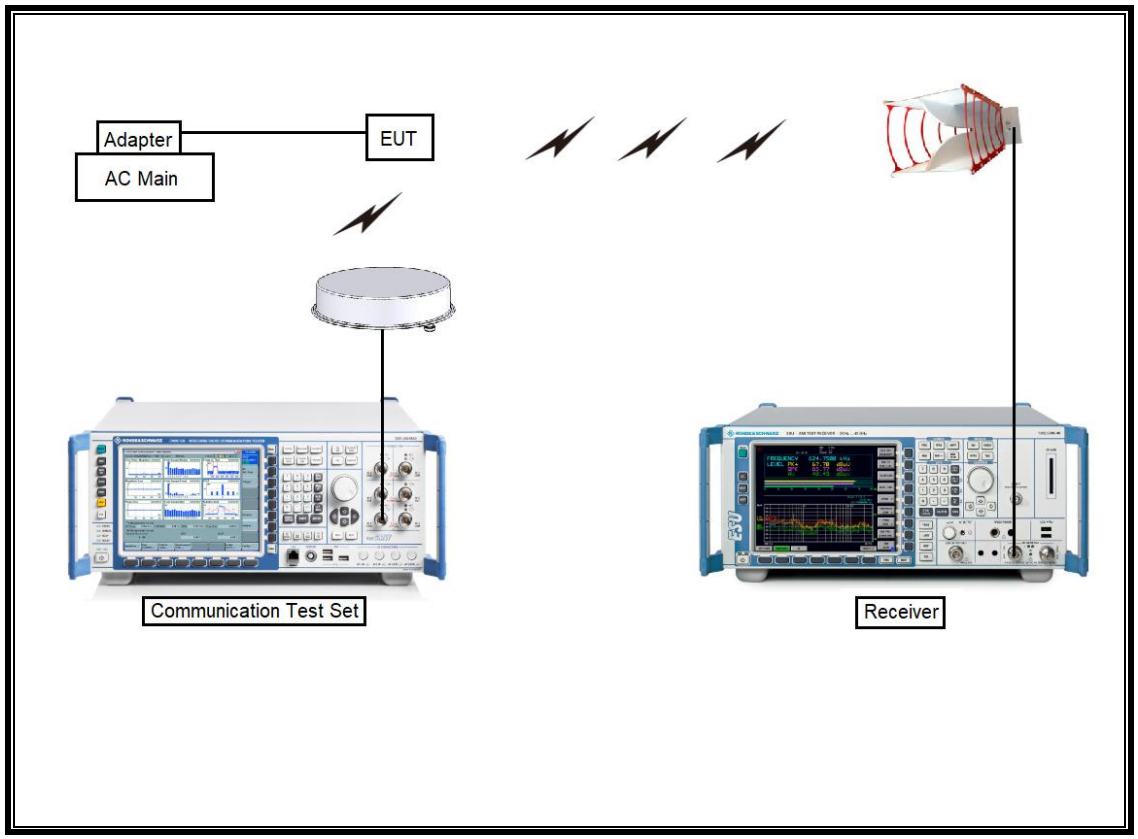
SETUP DIAGRAM FOR TESTS (CONDUCTED TEST SETUP)



SETUP DIAGRAM FOR TESTS (RADIATED TEST SETUP)



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6. TEST AND MEASUREMENT EQUIPMENT

The following test and measurement equipment was utilized for the tests documented in this report:

Test Equipment List				
Description	Manufacturer	Model	S/N	Cal Due
Antenna, Tuned Dipole 400~1000 MHz	ETS	3121D DB4	00164753	01-31-21
Directional Antenna	Cobham	FPA3-0.8-6.0R/1329	110367-0003	N/A
Directional Antenna	Cobham	FPA3-0.8-6.0R/1329	80108-0004	N/A
Antenna, Horn, 40 GHz	ETS	3116C	00166155	08-04-22
Preamplifier	ETS	3116C-PA	00168841	08-06-21
Antenna, Horn, 40 GHz	ETS	3116C	00168645	10-02-21
Antenna, Bilog, 30MHz-1GHz	SCHWARZBECK	VULB9163	750	08-19-22
Antenna, Bilog, 30MHz-1GHz	SCHWARZBECK	VULB9163	845	08-13-22
Antenna, Bilog, 30MHz-1GHz	SCHWARZBECK	VULB9163	749	08-13-22
Antenna, Horn, 18 GHz	ETS	3115	00167211	07-27-22
Antenna, Horn, 18 GHz	ETS	3115	00161451	08-15-22
Antenna, Horn, 18 GHz	ETS	3117	00168724	07-27-22
Antenna, Horn, 18 GHz	ETS	3117	00168717	08-15-22
Communications Test Set	R&S	CMW500	115331	08-03-21
DC Power Supply	Agilent / HP	E3640A	MY54226395	08-05-21
Preamplifier, 1000 MHz	Sonoma	310N	341282	08-03-21
Preamplifier, 1000 MHz	Sonoma	310N	370599	08-06-21
Preamplifier, 1000 MHz	Sonoma	310N	351741	08-03-21
Preamplifier, 18 GHz	Miteq	AFS42-00101800-25-S-42	1876511	08-03-21
Preamplifier, 18 GHz	Miteq	AFS42-00101800-25-S-42	2029169	08-04-21
Preamplifier, 18 GHz	Miteq	AFS42-00101800-25-S-42	1896138	08-03-21
Spectrum Analyzer	Keysight	N9030B	MY57143717	08-05-21
EMI Test Receive, 40 GHz	R&S	ESU40	100439	08-03-21
EMI Test Receive, 40 GHz	R&S	ESU40	100457	08-03-21
Direcitonal Antenna	Cobham	FPA3-0.8-6.0R/1329	80108-0004	N/A
High Pass Filter 1.2GHz	Micro-Tronics	HPM50108-02	G005	08-05-21
High Pass Filter 1.2GHz	Micro-Tronics	HPM50108-02	G006	08-05-21
High Pass Filter 2.8GHz	Micro-Tronics	HPM50111-02	010	08-05-21
High Pass Filter 2.8GHz	Micro-Tronics	HPM50111-02	011	08-05-21
High Pass Filter 4GHz	Micro-Tronics	HPM50118-02	G001	08-05-21
High Pass Filter 4GHz	Micro-Tronics	HPM50118-02	G002	08-05-21
Attenuator	PASTERNACK	PE7087-10	A009	08-05-21
Attenuator	PASTERNACK	PE7087-10	A001	08-03-21
Attenuator	PASTERNACK	PE7087-10	A008	08-03-21
Attenuator	PASTERNACK	PE7004-10	2	08-04-21
Attenuator	PASTERNACK	PE7395-10	A011	08-05-21
Antenna, Loop, 9kHz-30MHz	R&S	HFH2-Z2	100418	10-02-21
Temperature Chamber	ESPEC	SH-642	93001109	08-04-21
Power Splitter	MINI-CIRCUITS	WA1534	UL001	02-05-21
Power Splitter	MINI-CIRCUITS	WA1534	UL002	02-05-21
UL Software				
Description	Manufacturer	Model	Version	
Antenna port test software	UL	CLT	Ver 2.5	

7. SUMMARY TABLE

FCC Part Section	Test Description	Test Limit	Test Condition	Test Result
2.1049	Occupied Band width (99%)	N/A	Conducted	Pass
27.53(m)	Conducted Spurious Emission	-25 dBm		Pass
27.53(m)	Emission mask	Section 9.2.2		Pass
2.1046	Conducted output power	N/A		Pass
27.54	Frequency Stability	2.5PPM		Pass
27.50(h)(2)	Equivalent Isotropic Radiated Power	33dBm	Radiated	Pass
27.53 (m)	Radiated Spurious Emission	-25dBm		Pass

8. PEAK TO AVERAGE RATIO

Test Procedure

Per KDB 971168 D01 Power Meas License Digital Systems v03r01;

The transmitter output was connected to a CMW500 Test Set and configured to operate at maximum power. The PAR were measured on the Spectrum Analyzer.

Test Spec

In addition, when the transmitter power is measured in terms of average value, the peak-to-average ratio of the power shall not exceed 13 dB.

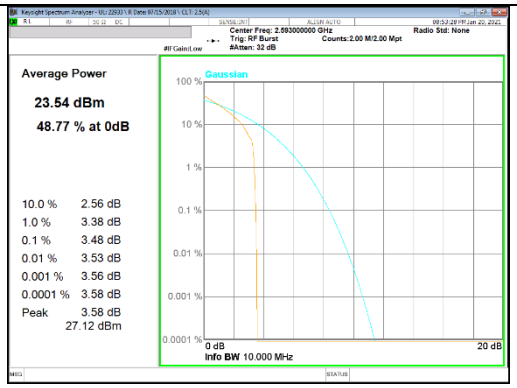
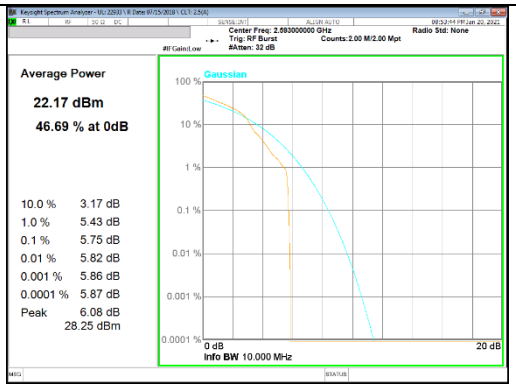
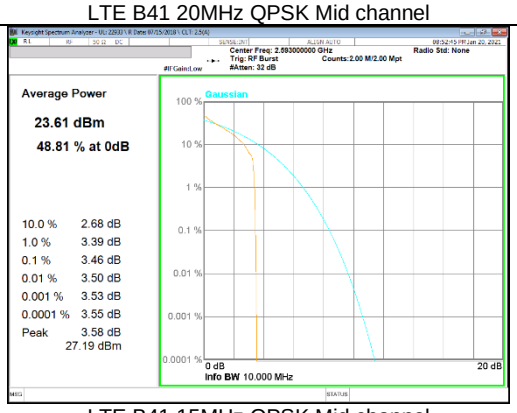
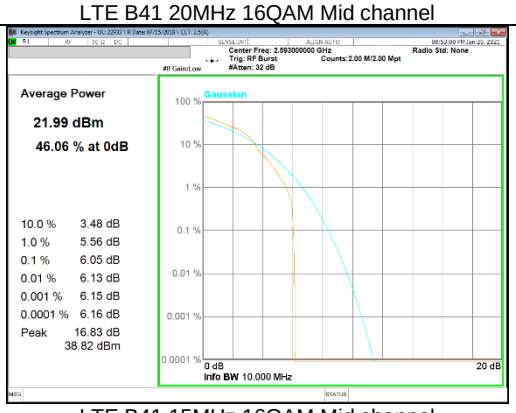
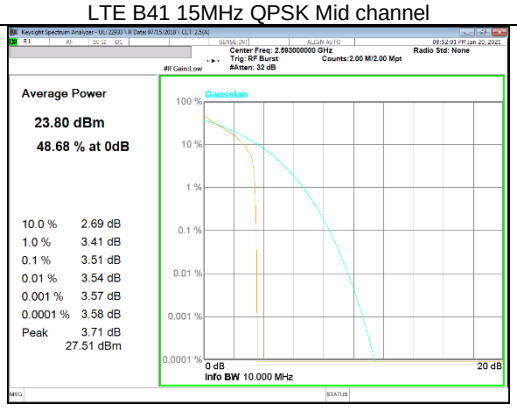
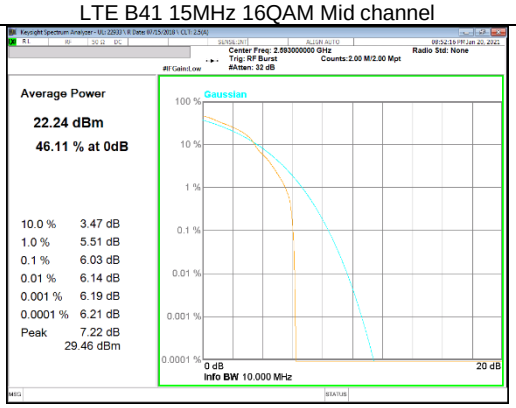
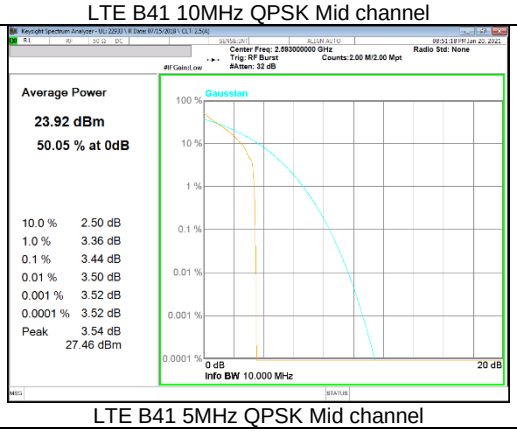
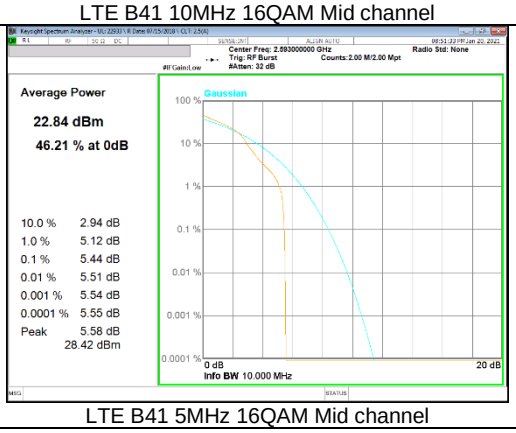
Note

The modulations (QPSK, 16QAM, 64QAM) were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

RESULTS

8.1. CONDUCTED PEAK TO AVERAGE RESULT

LTE Band 41

LTE Band 41 20 MHz	 LTE B41 20MHz QPSK Mid channel	 LTE B41 20MHz 16QAM Mid channel
LTE Band 41 15 MHz	 LTE B41 15MHz QPSK Mid channel	 LTE B41 15MHz 16QAM Mid channel
LTE Band 41 10 MHz	 LTE B41 10MHz QPSK Mid channel	 LTE B41 10MHz 16QAM Mid channel
LTE Band 41 5 MHz	 LTE B41 5MHz QPSK Mid channel	 LTE B41 5MHz 16QAM Mid channel

9. LIMITS AND CONDUCTED RESULTS

9.1. OCCUPIED BANDWIDTH

RULE PART(S)

FCC: §2.1049

LIMITS

For reporting purposes only

TEST PROCEDURE

The transmitter output was connected to a calibrated coaxial cable and coupler, the other end of which was connected to a spectrum analyzer. The occupied bandwidth was measured with the spectrum analyzer at the middle channel in each band. The -26dB bandwidth was also measured and recorded.

(KDB 971168 D01 Power Meas License Digital Systems v03r01)

RESULTS

See the following pages.

- LTE Band 41

Band	BW	Modulation	Channel	f [MHz]	99% BW (MHz)	-26dB BW (MHz)
LTE B41	20M	QPSK	40620	2593.0	17.874	19.270
		16QAM			17.913	20.870
	15M	QPSK	40620	2593.0	13.428	16.510
		16QAM			13.424	15.330
	10M	QPSK	40620	2593.0	8.955	9.921
		16QAM			8.960	9.976
	5M	QPSK	40620	2593.0	4.504	5.194
		16QAM			4.493	4.922

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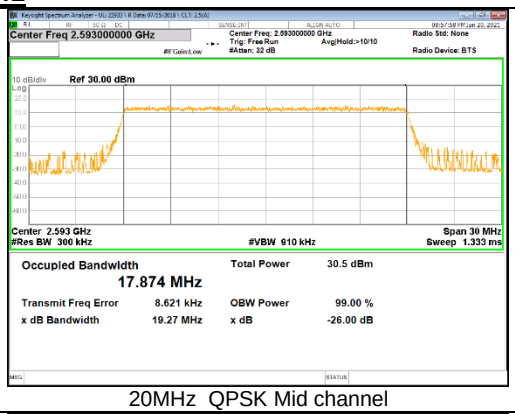
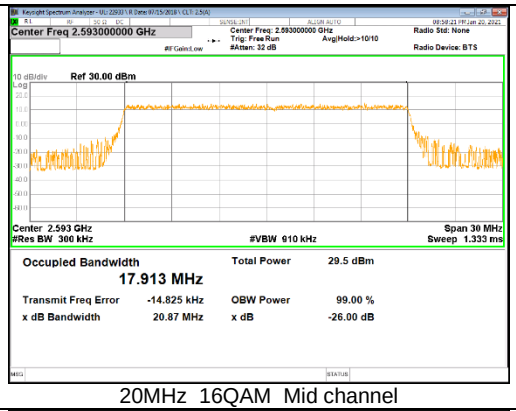
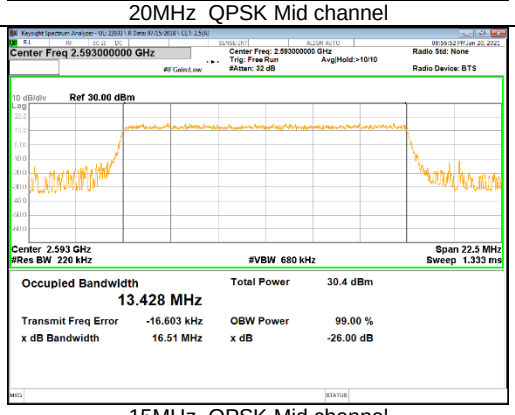
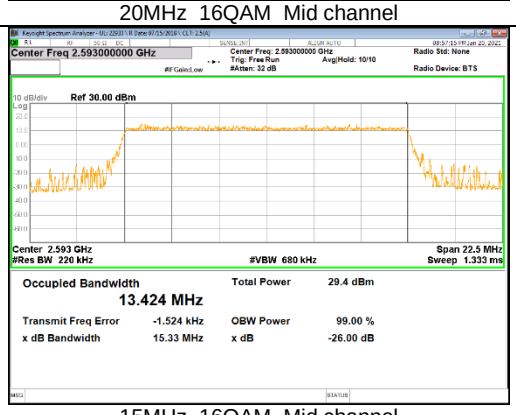
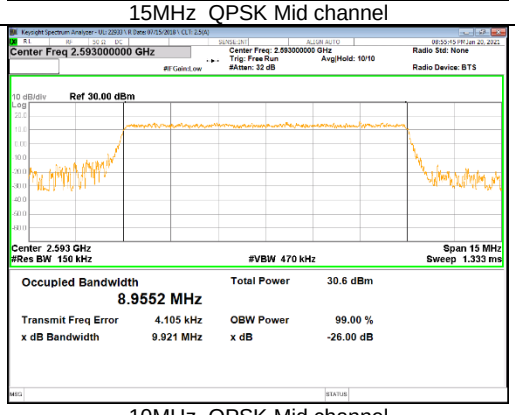
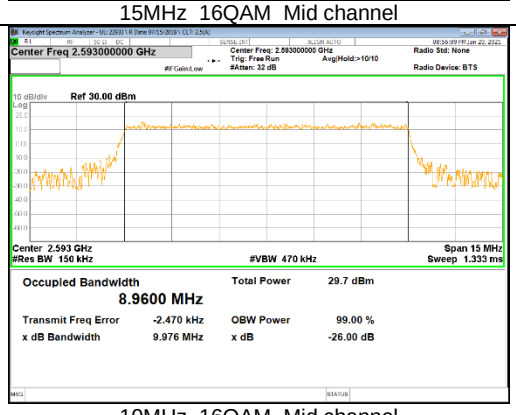
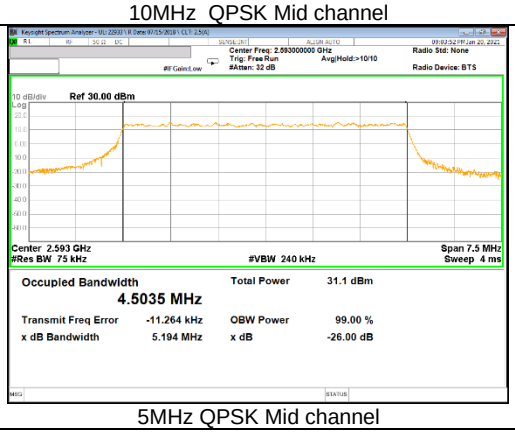
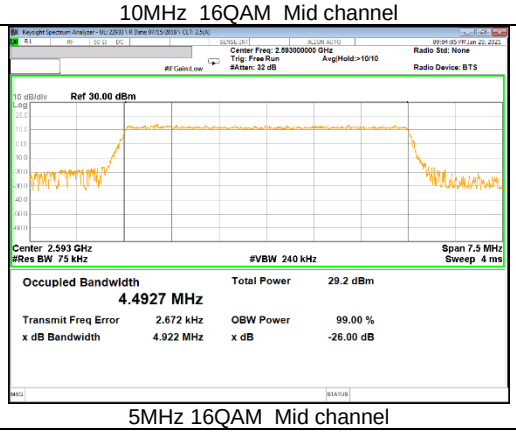
9.1.1. OCCUPIED BANDWIDTH RESULTS

LTE Band 41

Band 41 20MHz	 20MHz QPSK Mid channel	 20MHz 16QAM Mid channel
Band 41 15MHz	 15MHz QPSK Mid channel	 15MHz 16QAM Mid channel
Band 41 10MHz	 10MHz QPSK Mid channel	 10MHz 16QAM Mid channel
Band 41 5MHz	 5MHz QPSK Mid channel	 5MHz 16QAM Mid channel

9.2. BAND EDGE EMISSIONS

RULE PART(S)

FCC: §27. 53

LIMITS

(m) (4) For mobile digital stations, the attenuation factor shall be not less than 40 + 10 log (P) dB on all frequencies between the channel edge and 5 megahertz from the channel edge, 43 + 10 log (P) dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and 55 + 10 log (P) dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section. In addition, the attenuation factor shall not be less that 43 + 10 log (P) dB on all frequencies between 2490.5 MHz and 2496 MHz and 55 + 10 log (P) dB at or below 2490.5 MHz. Mobile Satellite Service licensees operating on frequencies below 2495 MHz may also submit a documented interference complaint against BRS licensees operating on channel BRS Channel 1 on the same terms and conditions as adjacent channel BRS or EBS licensees.

TEST PROCEDURE

Per KDB 971168 D01 Power Meas License Digital Systems v03r01
The transmitter output was connected to a CMW500 Test Set and configured to operate at maximum power. The band edge emissions were measured at the required operating frequencies in each band on the Spectrum Analyzer.

LTE

a) Set the RBW = 1 ~ 1.5 % of OBW(Typically limited to a minimum RBW of 1% of the OBW)
b) Set VBW ≥ 3 × RBW;
c) Set span ≥ 1.5 times the OBW;
d) Sweep time ≥ Auto;
e) Detector = RMS;
f) Ensure that the number of measurement points ≥ 2*Span/RBW;
g) Trace mode = Average (100);

NOTE1

Note that the spurious emissions outside of the channel include narrowband signals. These signals are all below the -25dBm limits. Although the measurement bandwidth is less than the reference bandwidth of 1MHz no additional correction is applied as ANSI C63.26 section 4.2.3 only requires the correction to be applied when the OBW of the emission being measured is wider than the measurement bandwidth (Where the OBW of the signal under measurement is less than the RBW of the measuring instrument, no bandwidth correction or integration will be required.) Plots for low and high channels show the level of the emission measured with the reduced bandwidth and the level of the same emission measured using the integration method over the 1MHz reference bandwidth are very close, indicating the emissions are narrowband.

RESULTS

See the following pages.

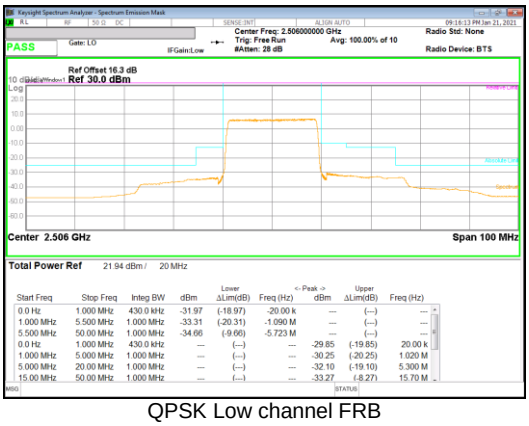
9.2.1. EMISSION MASK RESULT

LTE Band 41

Band 41

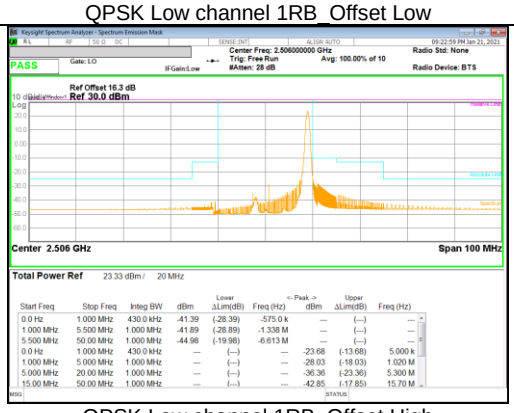
20MHz

QPSK

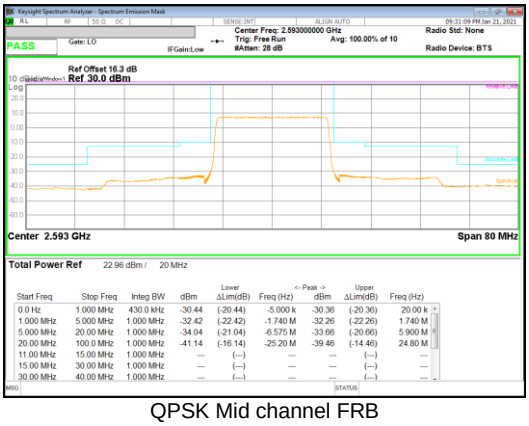


QPSK Low channel FRB

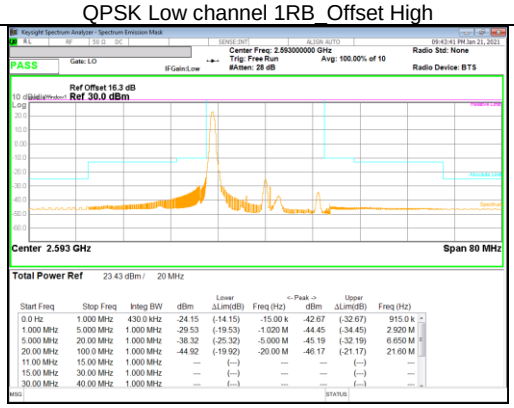
QPSK Low channel 1RB_Offset Low



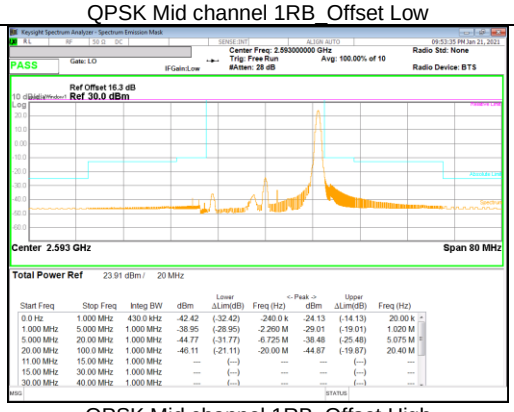
QPSK Low channel 1RB_Offset High



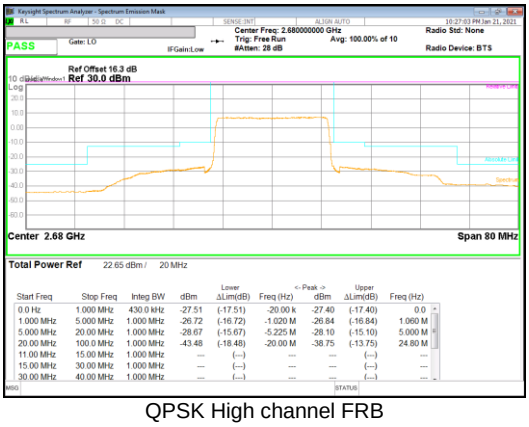
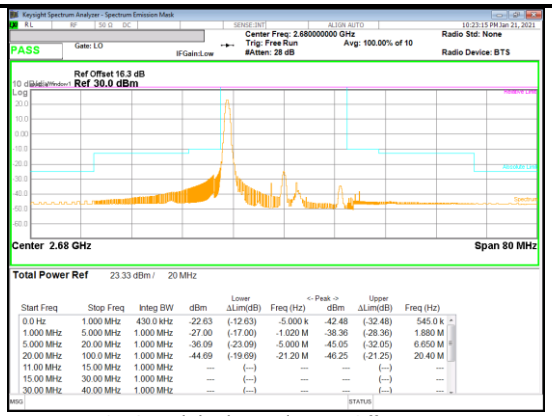
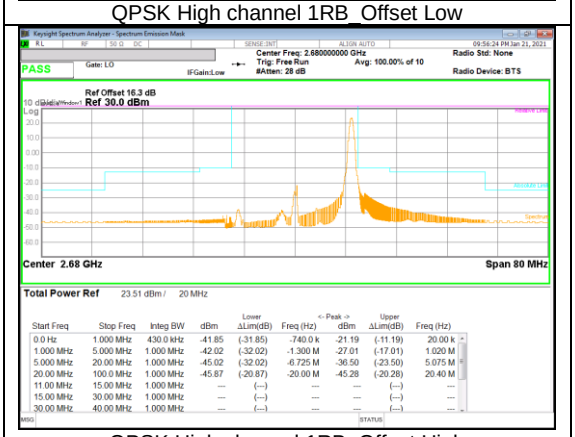
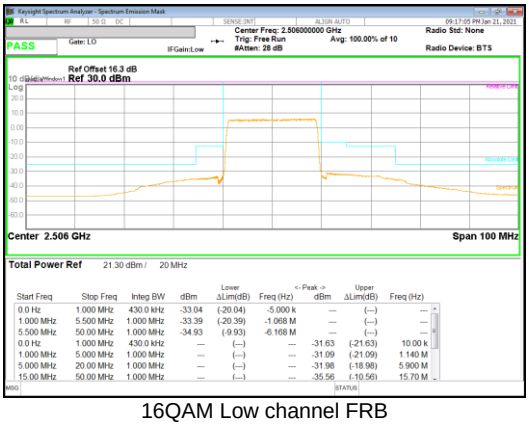
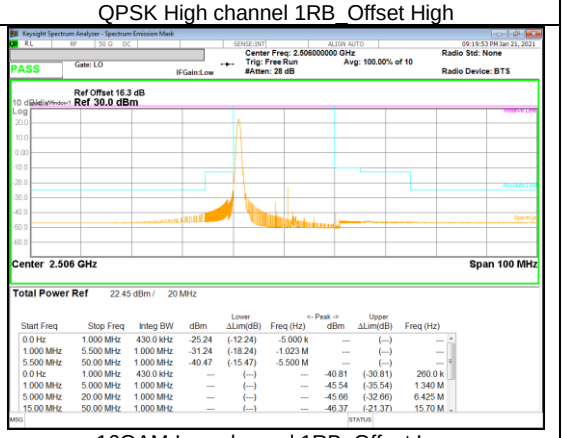
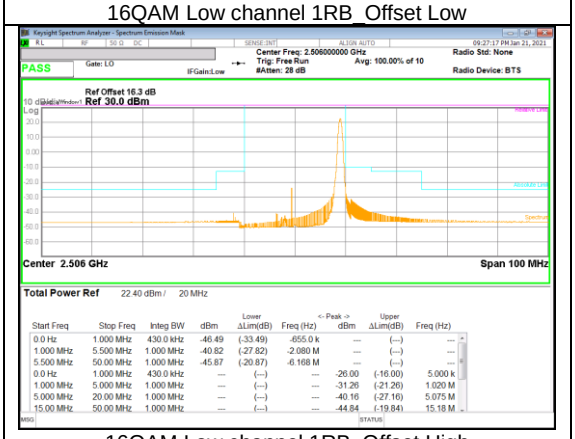
QPSK Mid channel FRB

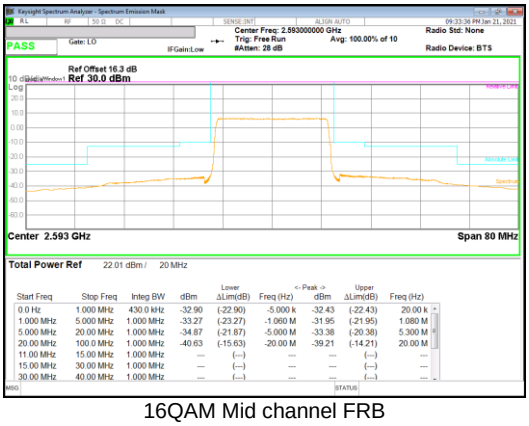
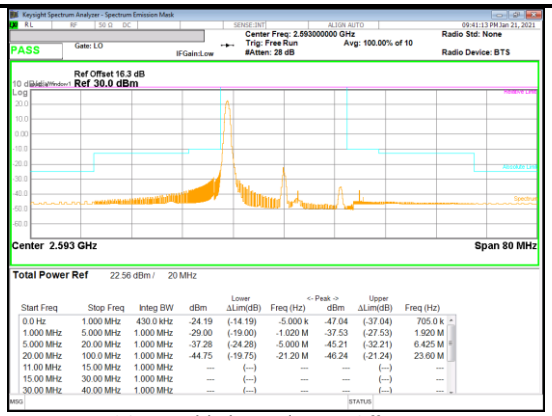
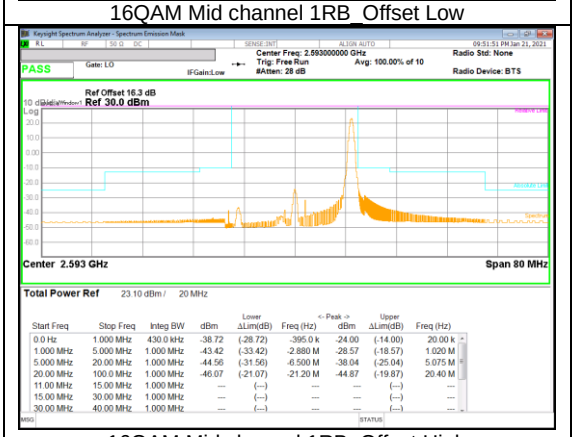
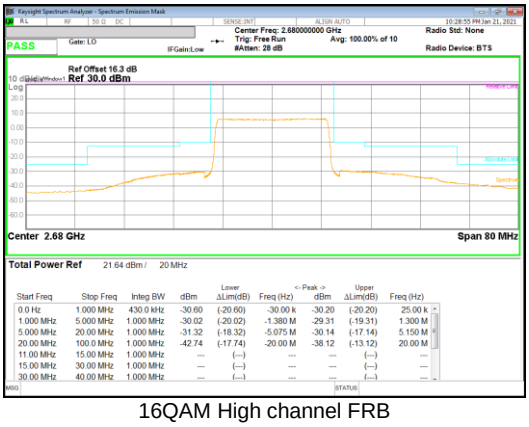
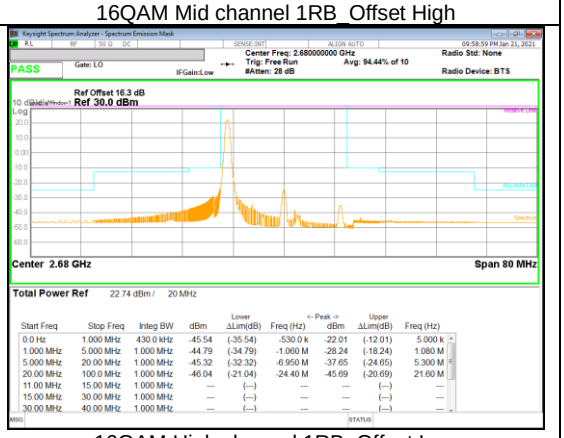
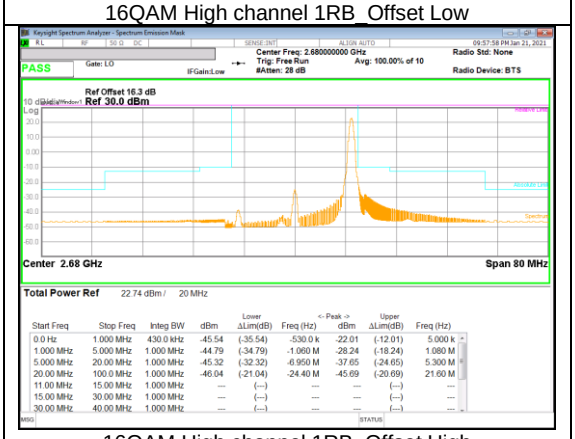


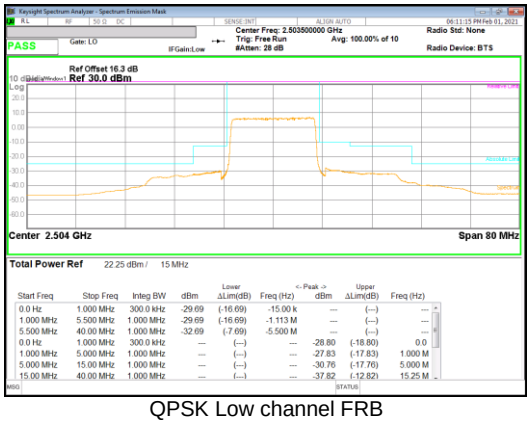
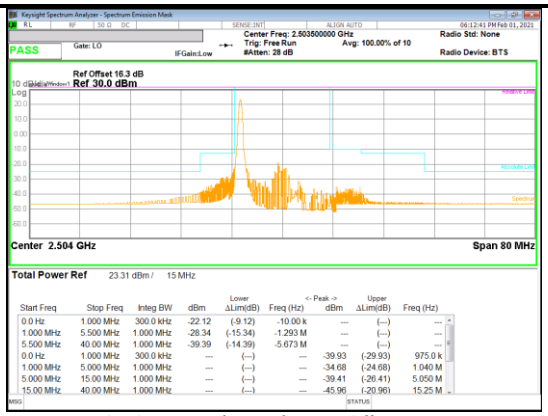
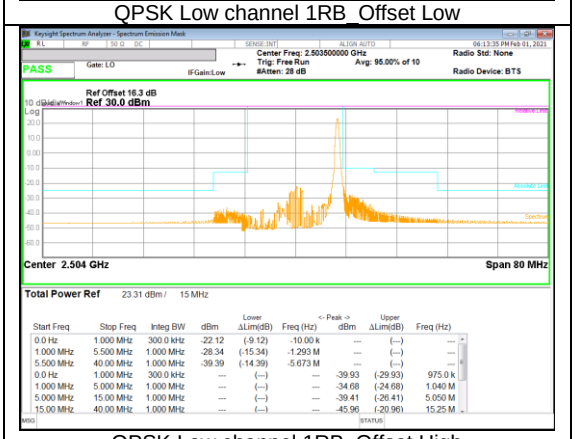
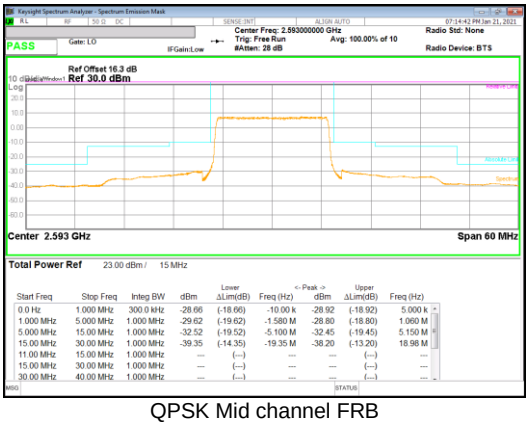
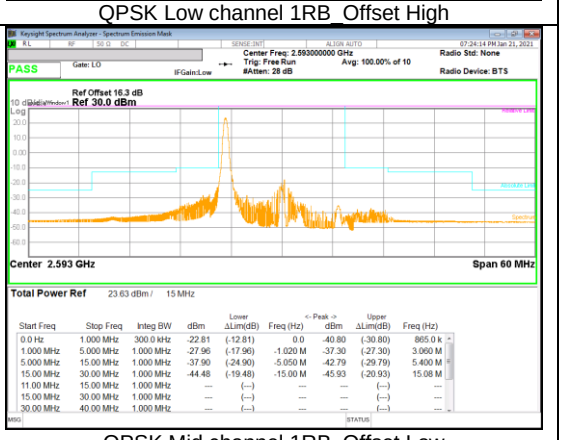
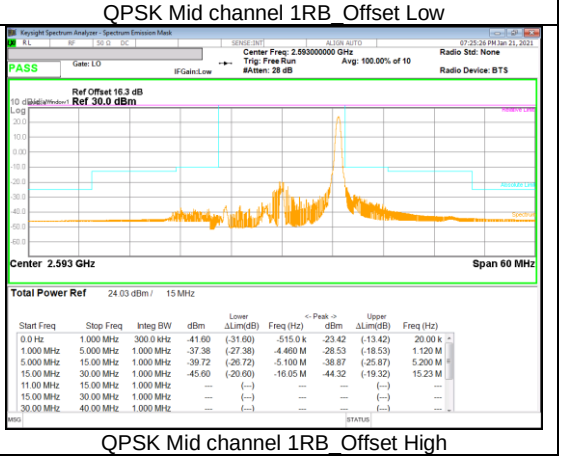
QPSK Mid channel 1RB_Offset Low

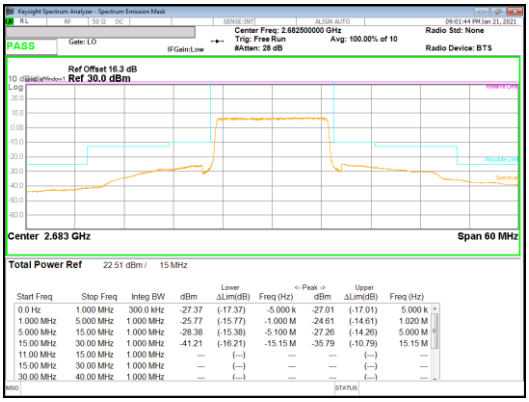
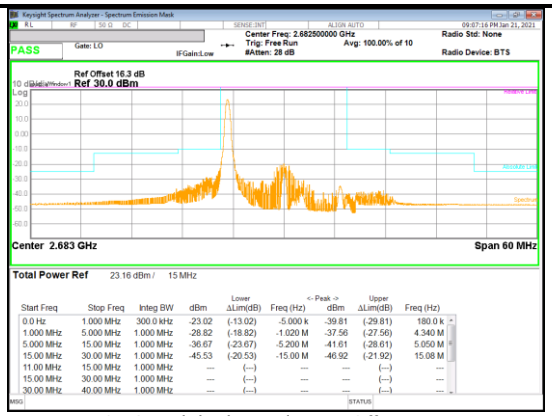
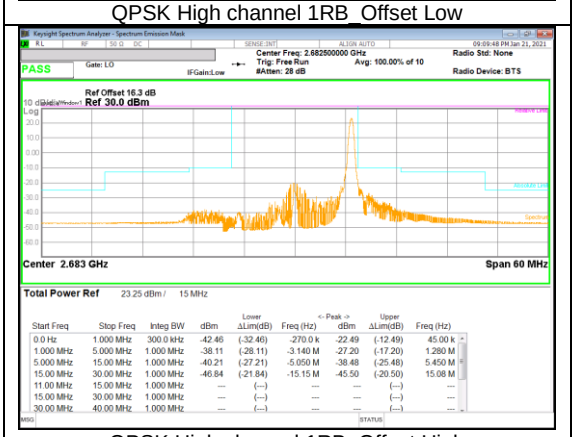
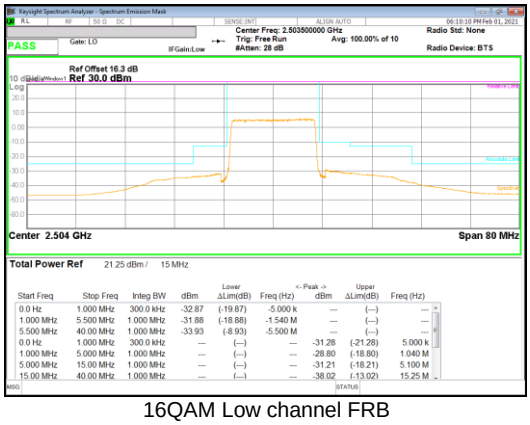
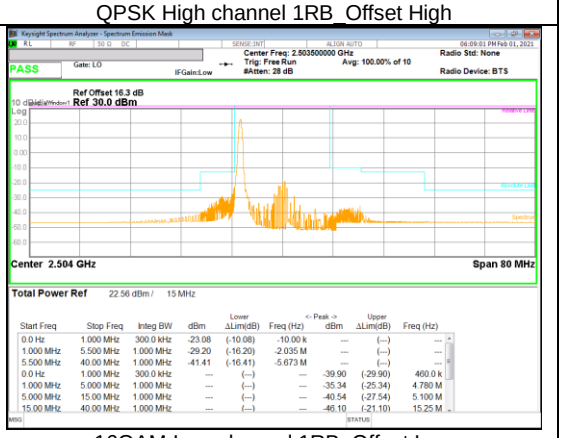
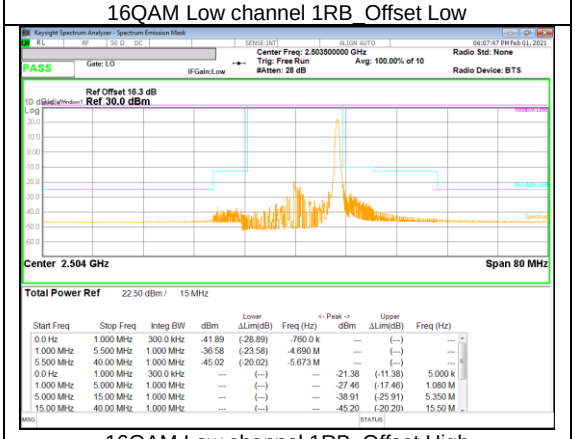


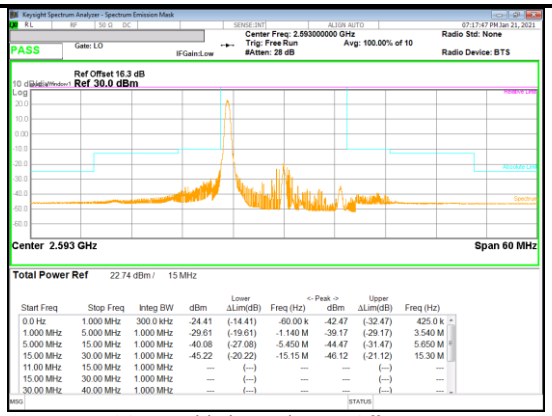
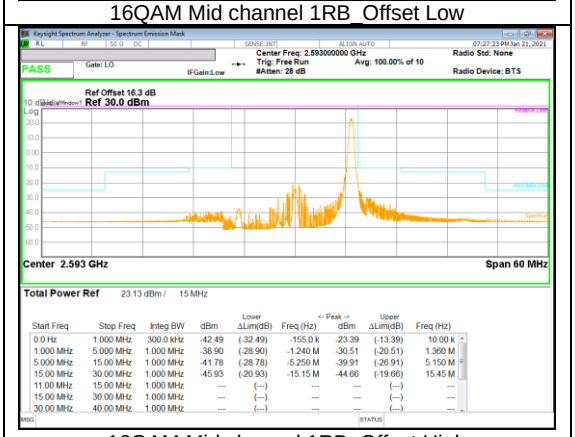
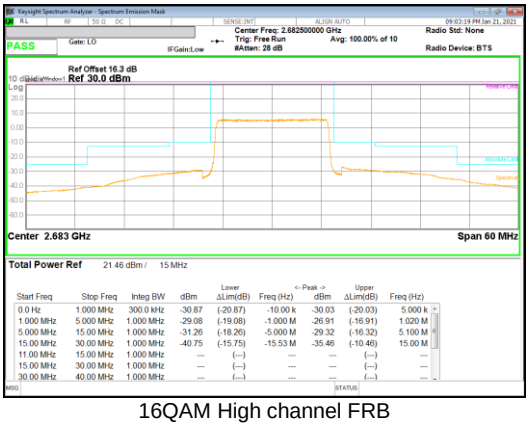
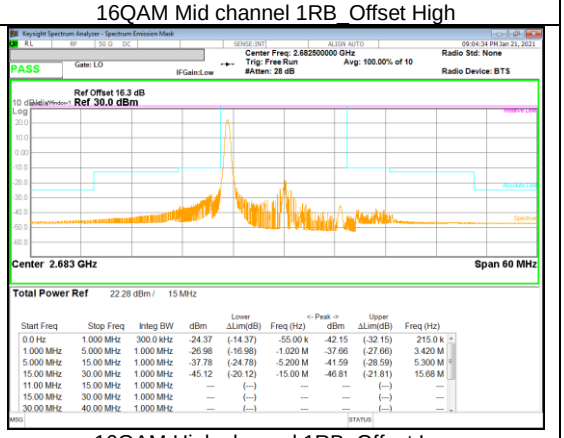
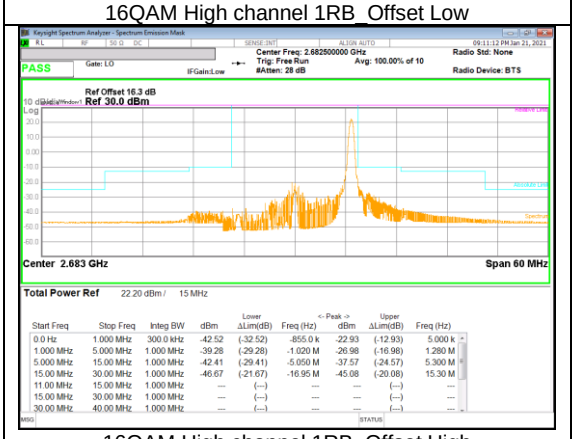
QPSK Mid channel 1RB_Offset High

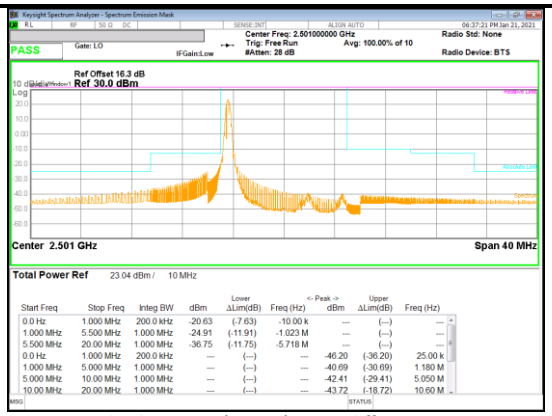
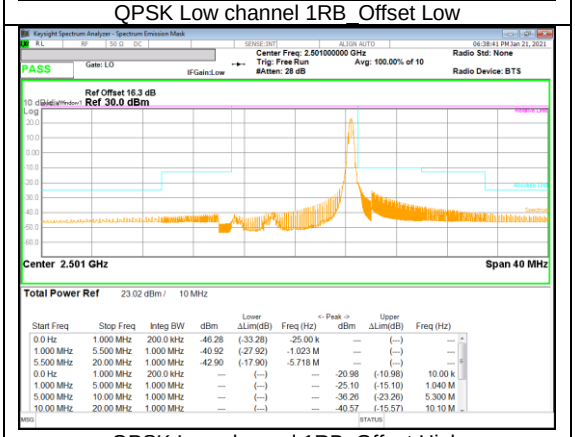
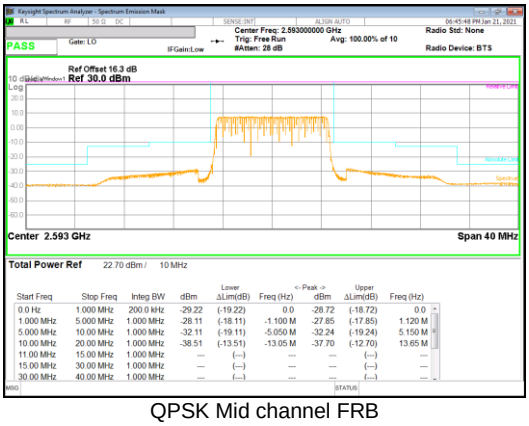
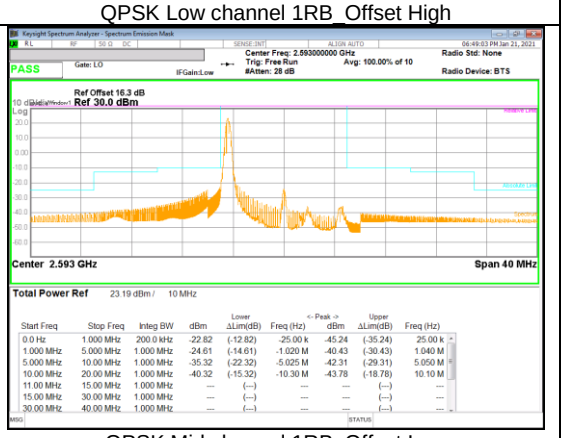
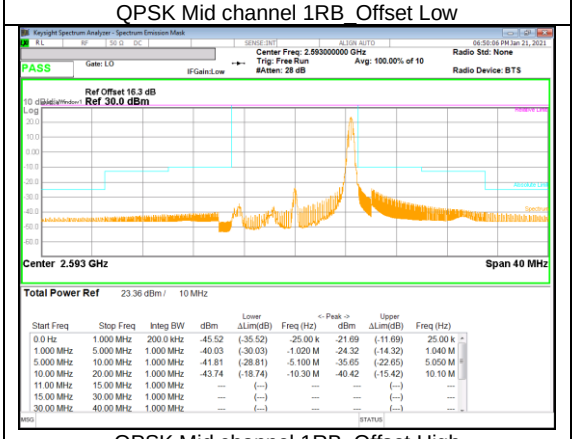
Band 41 20MHz QPSK	 QPSK High channel FRB	 QPSK High channel 1RB_Offset Low  QPSK High channel 1RB_Offset High
Band 41 20MHz 16QAM	 16QAM Low channel FRB	 16QAM Low channel 1RB_Offset Low  16QAM Low channel 1RB_Offset High

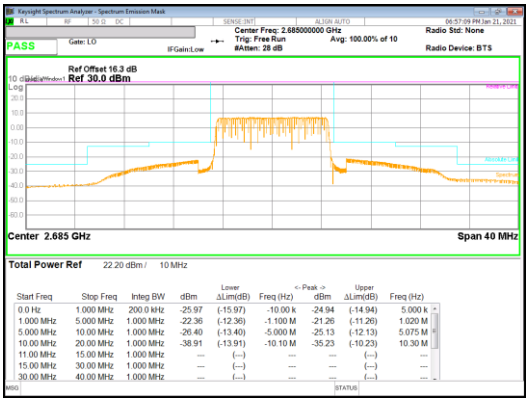
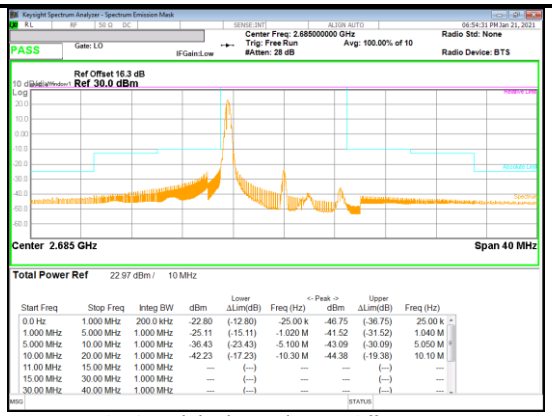
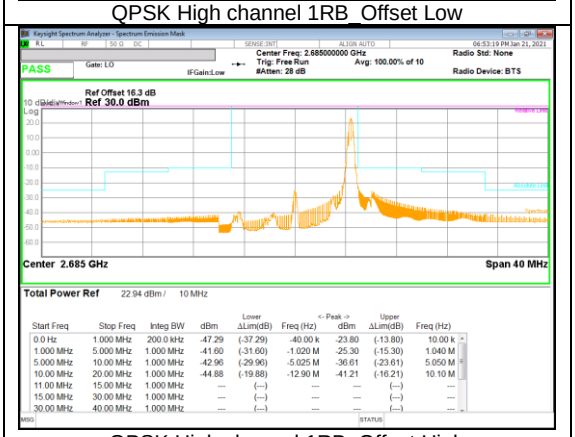
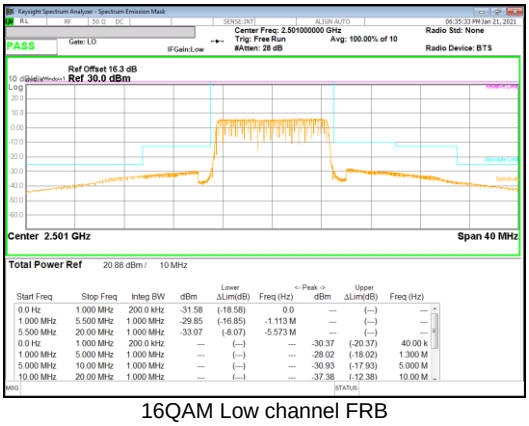
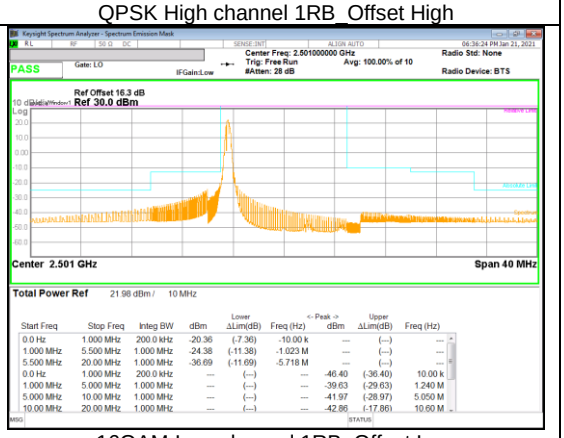
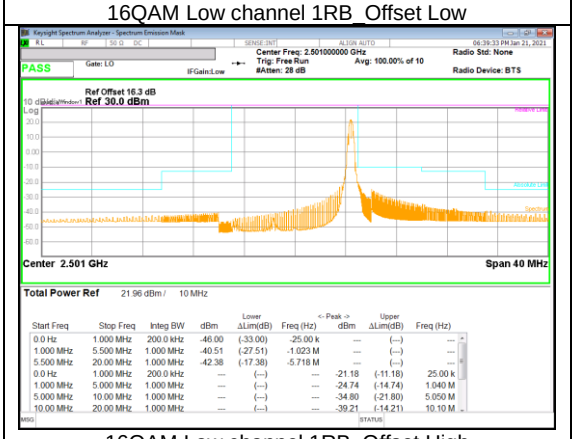
Band 41 20MHz 16QAM	 16QAM Mid channel FRB	 16QAM Mid channel 1RB_Offset Low
		 16QAM Mid channel 1RB_Offset High
	 16QAM High channel FRB	 16QAM High channel 1RB_Offset Low
		 16QAM High channel 1RB_Offset High

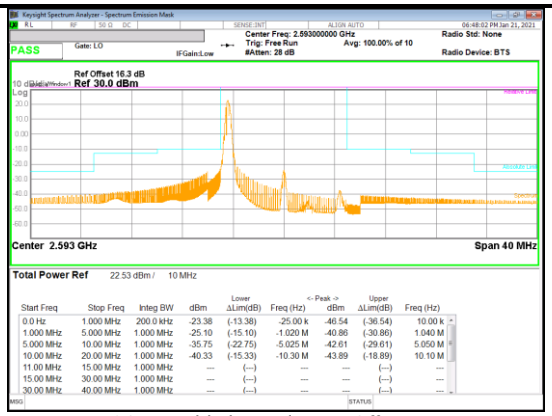
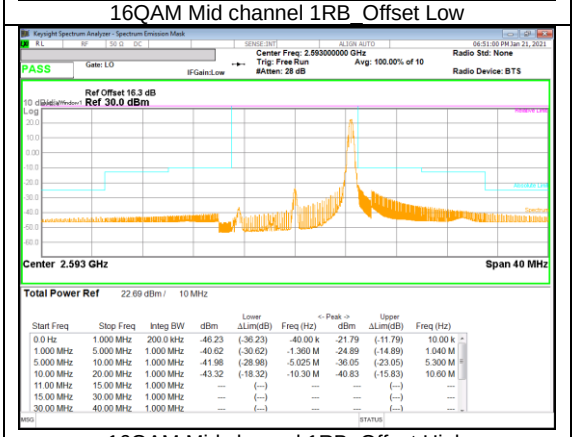
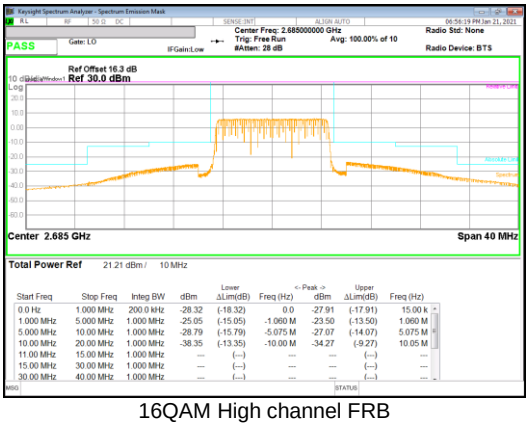
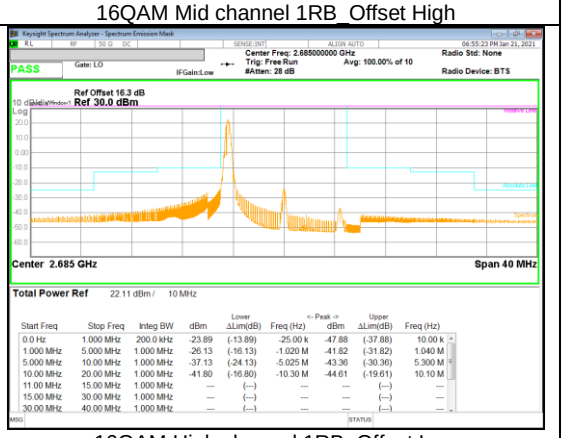
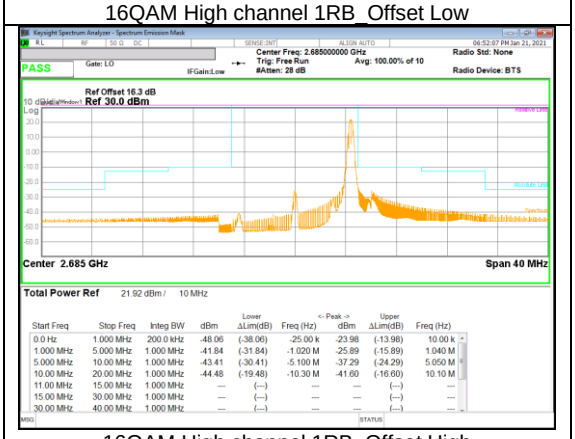
Band 41 15MHz QPSK	 QPSK Low channel FRB	 QPSK Low channel 1RB_Offset Low
		 QPSK Low channel 1RB_Offset High
	 QPSK Mid channel FRB	 QPSK Mid channel 1RB_Offset Low
		 QPSK Mid channel 1RB_Offset High

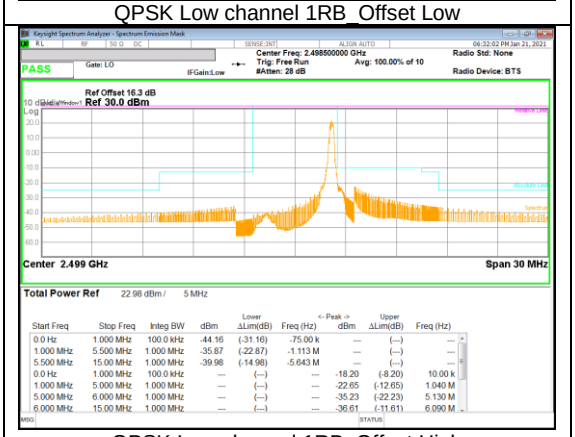
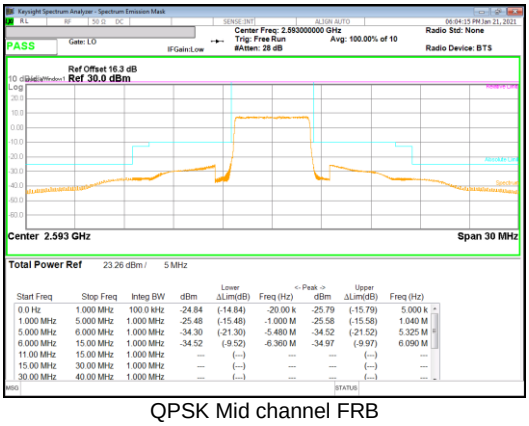
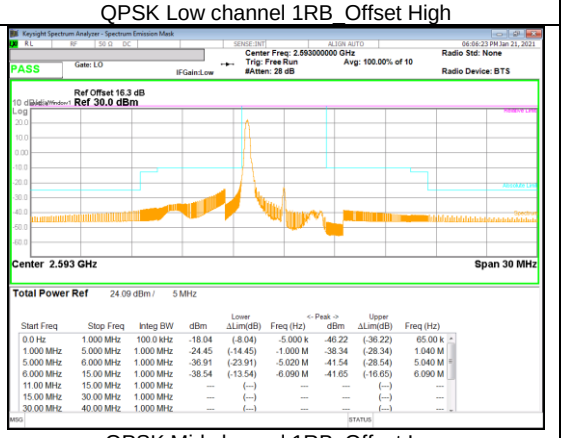
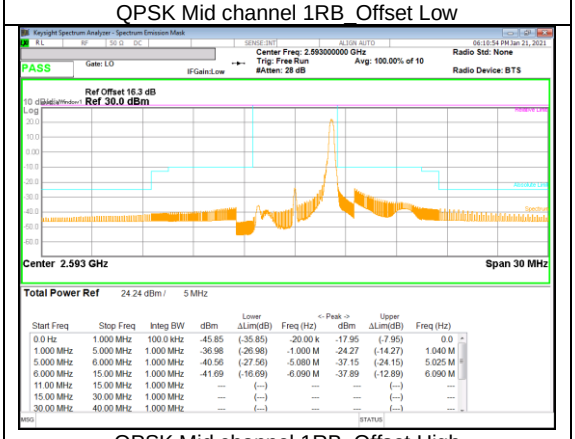
Band 41 15MHz QPSK	 QPSK High channel FRB	 QPSK High channel 1RB_Offset Low  QPSK High channel 1RB_Offset High
Band 41 15MHz 16QAM	 16QAM Low channel FRB	 16QAM Low channel 1RB_Offset Low  16QAM Low channel 1RB_Offset High

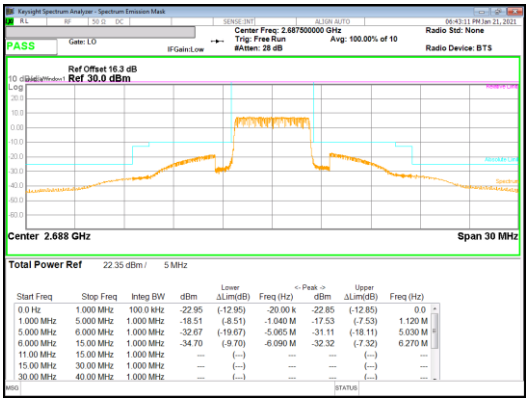
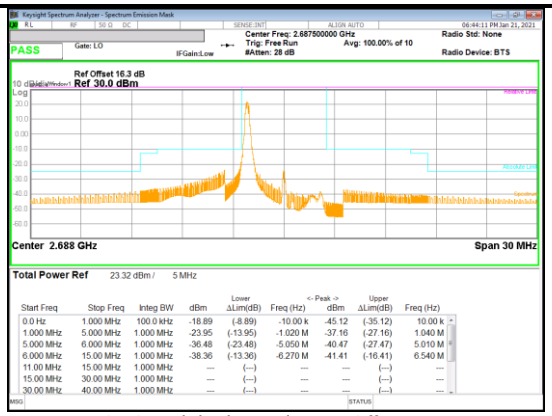
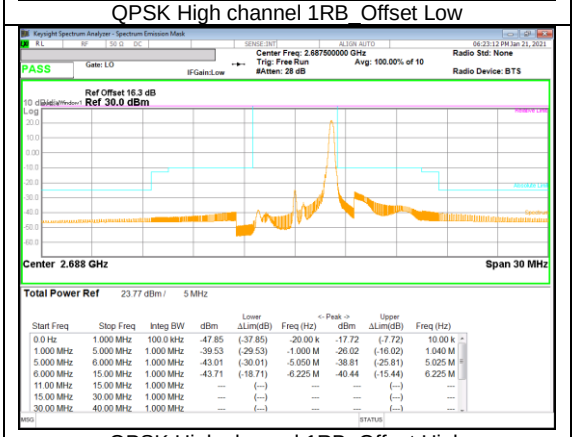
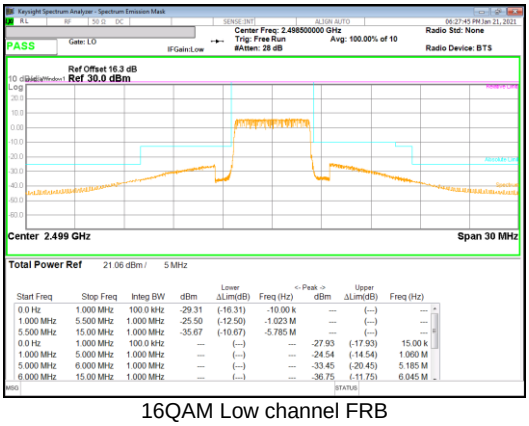
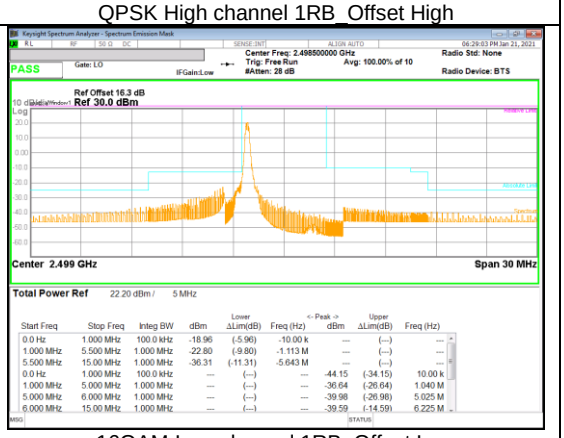
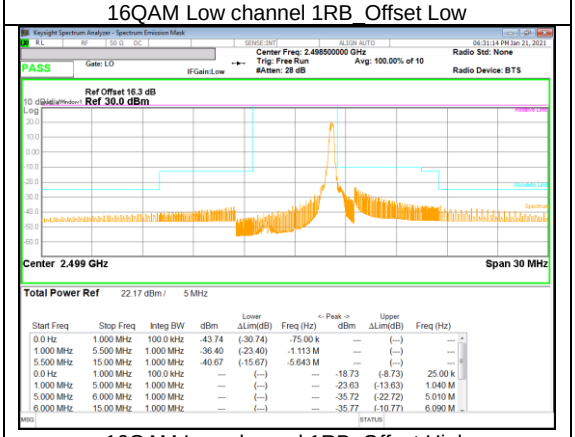
Band 41 15MHz 16QAM	 16QAM Mid channel FRB	 16QAM Mid channel 1RB_Offset Low
		 16QAM Mid channel 1RB_Offset High
	 16QAM High channel FRB	 16QAM High channel 1RB_Offset Low
		 16QAM High channel 1RB_Offset High

Band 41 10MHz QPSK	 QPSK Low channel FRB	 QPSK Low channel 1RB_Offset Low
		 QPSK Low channel 1RB_Offset High
	 QPSK Mid channel FRB	 QPSK Mid channel 1RB_Offset Low
		 QPSK Mid channel 1RB_Offset High

Band 41 10MHz QPSK	 QPSK High channel FRB	 QPSK High channel 1RB_Offset Low  QPSK High channel 1RB_Offset High
Band 41 10MHz 16QAM	 16QAM Low channel FRB	 16QAM Low channel 1RB_Offset Low  16QAM Low channel 1RB_Offset High

Band 41 10MHz 16QAM	 16QAM Mid channel FRB	 16QAM Mid channel 1RB_Offset Low
		 16QAM Mid channel 1RB_Offset High
	 16QAM High channel FRB	 16QAM High channel 1RB_Offset Low
		 16QAM High channel 1RB_Offset High

Band 41 5MHz QPSK	 QPSK Low channel FRB	 QPSK Low channel 1RB_Offset Low
		 QPSK Low channel 1RB_Offset High
	 QPSK Mid channel FRB	 QPSK Mid channel 1RB_Offset Low
		 QPSK Mid channel 1RB_Offset High

Band 41 5MHz QPSK	 QPSK High channel FRB	 QPSK High channel 1RB_Offset Low  QPSK High channel 1RB_Offset High
Band 41 5MHz 16QAM	 16QAM Low channel FRB	 16QAM Low channel 1RB_Offset Low  16QAM Low channel 1RB_Offset High